











SN74TVC3306

SCDS112D -MARCH 2001-REVISED DECEMBER 2014

SN74TVC3306 Dual Voltage Clamp

Features

- Designed to Be Used in Voltage-Limiting Applications
- 3.5-Ω On-State Connection Between Ports A and B
- Flow-Through Pinout for Ease of Printed Circuit **Board Trace Routing**
- Direct Interface With GTL+ Levels
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model
 - 200-V Machine Model
 - 1000-V Charged-Device Model

Applications

- Voltage Level Translation
- Signal Switching
- **Bus Isolation**

3 Description

The SN74TVC3306 device provides three parallel NMOS pass transistors with a common unbuffered gate. The low on-state resistance of the switch allows connections to be made with minimal propagation delay.

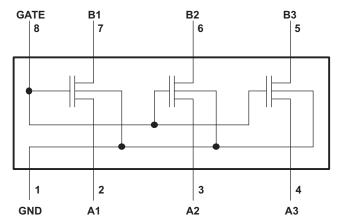
The device can be used as a dual switch, with the gates cascaded together to a reference transistor. The low-voltage side of each pass transistor is limited to a voltage set by the reference transistor. This is done to protect components with inputs that are sensitive to high-state voltage-level overshoots.

Device Information⁽¹⁾

PART NUMBER	ER PACKAGE BODY SIZE (N			
CN74TVC220C	SM8 (8)	3.00 mm x 2.80 mm		
SN74TVC3306	US8 (8)	2.30 mm x 2.00 mm		

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Simplified Schematic



The SN74TVC3306 device has bidirectional capability across many voltage levels. The voltage levels documented in this data sheet are examples.



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5 Revision History

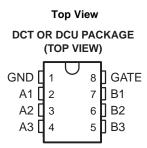
Changes from Revision C (March 2002) to Revision D

Page

•	Added Applications, Device Information table, Pin Functions table, Handling Ratings table, Thermal Information table, Typical Characteristics, Feature Description section, Device Functional Modes, Application and	
	Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section.	. 1
•	Deleted Ordering Information table.	. 1
•	Changed the R _{ON} parameter in the <i>Electrical Characersitics</i> table.	. 5



6 Pin Configuration and Functions



Pin Functions

P	IN	TYPE	DESCRIPTION
NAME	NO.	TIPE	DESCRIPTION
A1	2	I/O	I/O of gate 1
A2	3	I/O	I/O of gate 1
A3	4	I/O	I/O of gate 1
B1	5	I/O	I/O of gate 2
B2	6	I/O	I/O of gate 2
B3	7	I/O	I/O of gate 2
GATE	8	I	Gate pin. Set high to enable the switches. Connect to B1 (V _{BIAS}) for translation application.
GND	1	_	Ground



7 Specifications

7.1 Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
VI	Input voltage range (2)		-0.5	7	V
V _{I/O}	Input/output voltage range ⁽²⁾		-0.5	7	V
	Continuous channel current			128	mA
I _{IK}	Input clamp current	V _I < 0		-50	mA
T _{stg}	Storage temperature range		-65	150	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

7.2 ESD Ratings

			VALUE	UNIT
		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins (1)	2500	
V _(ESD)	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins (2)	2000	V

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

	<u> </u>			
		MIN	MAX	UNIT
V _{I/O}	Input/output voltage	0	5	V
V_{GATE}	GATE voltage	0	5	V
I _{PASS}	Pass transistor current		64	mA
T _A	Operating free-air temperature	-40	85	°C

7.4 Thermal Information

		SN74T	VC3306	
THERMAL METRIC ⁽¹⁾		DCT	DCU	UNIT
		8 PINS	8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	220	227	°C/W

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

⁽²⁾ The input and input/output negative-voltage ratings may be exceeded if the input and input/output clamp-current ratings are observed.

⁽²⁾ JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



7.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIO	NS	MIN	TYP ⁽¹⁾	MAX	UNIT
V _{IK}	I _I = -18 mA,	V _{GATE} = 0				-1.2	V
I _{IH}	$V_{I} = 5 V,$	$V_{GATE} = 0$				5	μΑ
C _{i(GATE)}	V _I = 3 V or 0				11		рF
C _{io(off)}	$V_0 = 3 \text{ V or } 0,$	$V_{GATE} = 0$			4	6	рF
C _{io(on)}	$V_0 = 3 \text{ V or } 0,$	$V_{GATE} = 3 V$			10.5	12.5	рF
			$V_{GATE} = 4.5 V$		3.5	5.5	
	$V_{I} = 0$,	$I_O = 64 \text{ mA}$	$V_{GATE} = 3 V$		4.7	7	
R _{on} (2)			$V_{GATE} = 2.3 V$		6.3	9.5	Ω
	V _I = 2.4 V,	I _O = 15 mA	V _{GATE} = 4.5 V		4.8	7.5	
	$V_{I} = 1.8 V,$	$I_O = 15 \text{ mA}$	V _{GATE} = 4.5 V		4.5	5	

⁽¹⁾ All typical values are at $T_A = 25$ °C.

7.6 Switching Characteristics (AC, $V_{GATE} = 3.3 \text{ V}$, Translating Down)

over recommended operating free-air temperature range, $V_{GATE} = 3.3 \text{ V}$, $V_{IH} = 3.3 \text{ V}$, $V_{IL} = 0$, and $V_{M} = 1.15 \text{ V}$ (unless otherwise noted) (see Figure 2)

PARAMETER	FROM	то	C _L = 5	0 pF	C _L = 3	0 pF	C _L = 1	5 pF	UNIT
	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
t _{PLH}	A - :: D	D or A	0	8.0	0	0.6	0	0.3	20
t _{PHL}	A or B	B or A	0	1.2	0	1	0	0.5	ns

7.7 Switching Characteristics (AC, V_{GATE} = 2.5 V, Translating Down)

over recommended operating free-air temperature range, $V_{GATE} = 2.5 \text{ V}$, $V_{IH} = 2.5 \text{ V}$, $V_{IL} = 0$, and $V_{M} = 0.75 \text{ V}$ (unless otherwise noted) (see Figure 2)

PARAMETER	FROM	то	C _L = 5	0 pF	C _L = 3	0 pF	C _L = 1	5 pF	UNIT
	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
t _{PLH}	A or B	D or A	0	1	0	0.7	0	0.4	20
t _{PHL}		B or A	0	1.3	0	1	0	0.6	ns

7.8 Switching Characteristics (AC, V_{GATE} = 3.3 V, Translating Up)

over recommended operating free-air temperature range, $V_{GATE} = 3.3 \text{ V}$, $V_{IH} = 2.3 \text{ V}$, $V_{IL} = 0$, $V_{T} = 3.3 \text{ V}$, $V_{M} = 1.15 \text{ V}$, and $R_{L} = 300 \Omega$ (unless otherwise noted) (see Figure 2)

PARAMETER	FROM	то	C _L = 5	0 pF	C _L = 3	0 pF	C _L = 1	5 pF	UNIT
	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
t _{PLH}	A - :: D	B or A	0	0.9	0	0.6	0	0.4	20
t _{PHL}	A or B	D UI A	0	1.4	0	1.1	0	0.7	ns

7.9 Switching Characteristics (AC, $V_{GATE} = 2.5 \text{ V}$, Translating Up)

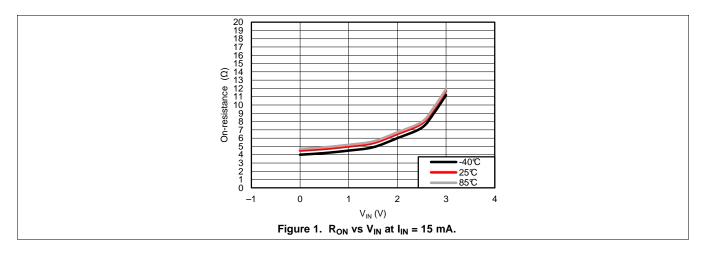
over recommended operating free-air temperature range, $V_{GATE} = 2.5 \text{ V}$, $V_{IH} = 1.5 \text{ V}$, $V_{IL} = 0$, $V_{T} = 2.5 \text{ V}$, $V_{M} = 0.75 \text{ V}$, and $R_{L} = 300 \Omega$ (unless otherwise noted) (see Figure 2)

PARAMETER	FROM	то	C _L = 50 pF		C _L = 30 pF		C _L = 15 pF		UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
t _{PLH}	A or D	D or A	0	1	0	0.6	0	0.4	ns
t _{PHL}	A or B	B or A	0	1.3	0	1.3	0	0.8	

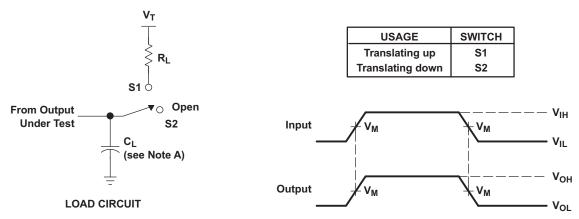
⁽²⁾ Measured by the voltage drop between the A and B terminals at the indicated current through the switch. On-state resistance is determined by the lowest voltage of the two (A or B) terminals.

TEXAS INSTRUMENTS

7.10 Typical Characteristics



8 Parameter Measurement Information



NOTES: A. C_L includes probe and jig capacitance.

B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , $t_f \leq$ 2 ns.

C. The outputs are measured one at a time, with one transition per measurement.

Figure 2. Load Circuit for Outputs



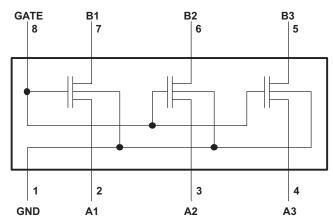
9 Detailed Description

9.1 Overview

The SN74TVC3306 device provides three parallel NMOS pass transistors with a common unbuffered gate. The low on-state resistance of the switch allows connections to be made with minimal propagation delay.

The device can be used as a dual switch, with the gates cascaded together to a reference transistor. The low-voltage side of each pass transistor is limited to a voltage set by the reference transistor. This is done to protect components with inputs that are sensitive to high-state voltage-level overshoots.

9.2 Functional Block Diagram



The SN74TVC3306 device has bidirectional capability across many voltage levels. The voltage levels documented in this data sheet are examples.

9.3 Feature Description

9.3.1 Voltage Clamping

The internal NMOS transistors allow the SN74TVC3306 device to act as a voltage clamp and be configured as a voltage level translator. See *Application and Implementation*.

9.4 Device Functional Modes

9.4.1 Voltage Clamping

Whenever the signal on the inputs on the side with V_{REF} goes higher than V_{REF} , the voltage clamps on the opposite side to the value of V_{DPU} due to the pullup resistors. In this case, the voltage is translating up. See *Application and Implementation*.

9.4.2 Voltage Passing

Whenever the signal on the inputs on the VREF side is lower than VREF, the signal will pass to the other side as intended. In this case, the low pulse is staying low (no translation). See *Application and Implementation*.

Product Folder Links: SN74TVC3306



10 Application and Implementation

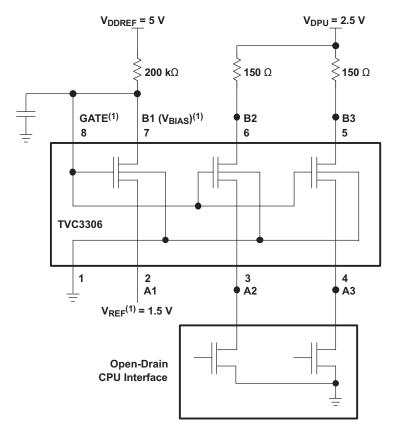
NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

10.1 Application Information

Because of the voltage-clamping mechanism, the SN74TVC3306 device performs best as a level translator for signals that have sharp edges (as opposed to analog audio signals).

10.2 Typical Application



V_{REF} and V_{BIAS} can be applied to any one of the pass transistors. GATE must be connected externally to V_{BIAS}

Figure 3. Typical Application Circuit



Typical Application (continued)

10.2.1 Design Requirements

10.2.1.1 Application Operating Conditions

Application Operating Conditions (See Figure 3)

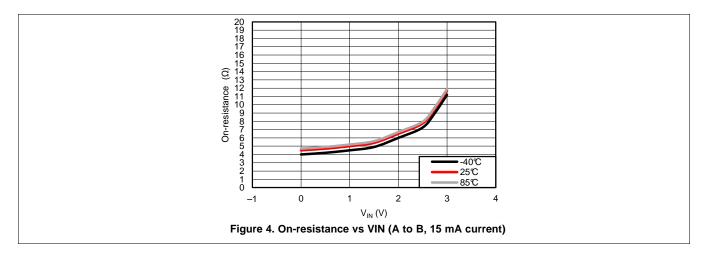
	Approximent operating containents (coo i igui	 ,			
		MIN	TYP ⁽¹⁾	MAX	UNIT
V_{BIAS}	BIAS voltage	V _{REF} + 0.6	2.1	5	V
V_{GATE}	GATE voltage	V _{REF} + 0.6	2.1	5	V
V_{REF}	Reference voltage	0	1.5	4.4	V
V_{DPU}	Drain pullup voltage	2.36	2.5	2.64	V
I _{PASS}	Pass-transistor current		14		mA
I _{REF}	Reference-transistor current		5		μΑ
T _A	Operating free-air temperature	-40		85	°C

⁽¹⁾ All typical values are at $T_A = 25$ °C.

10.2.2 Detailed Design Procedure

For the clamping configuration, the common GATE input must be connected to one side (An or Bn) of any one of the pass transistors, making that the V_{BIAS} connection of the reference transistor and the opposite side (Bn or An) the V_{REF} connection. When V_{BIAS} is connected through a 200-k Ω resistor to a 3-V to 5.5-V V_{CC} supply and V_{REF} is set to 0 V to V_{CC} – 0.6 V, the output of each switch has a maximum clamp voltage equal to V_{REF} . A filter capacitor on V_{BIAS} is recommended.

10.2.3 Application Curves





11 Power Supply Recommendations

A 200-k Ω resistor is recommended from the input to V_{CC} when the device is being used as a voltage clamp. A filter capacitor is recommended on B1 as well.

12 Layout

12.1 Layout Guidelines

If used, the filter capacitor should be placed as close to the input of the device as possible.

12.2 Layout Example

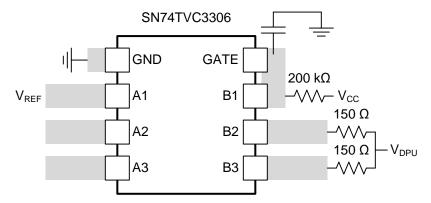


Figure 5. Layout example for voltage-clamp configuration

13 Device and Documentation Support

13.1 Trademarks

All trademarks are the property of their respective owners.

13.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

13.3 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.





10-Dec-2020

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SN74TVC3306DCTR	ACTIVE	SM8	DCT	8	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	FA6 (S, Y)	Samples
SN74TVC3306DCTRE4	ACTIVE	SM8	DCT	8	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	FA6 (S, Y)	Samples
SN74TVC3306DCUR	ACTIVE	VSSOP	DCU	8	3000	RoHS & Green	NIPDAU SN	Level-1-260C-UNLIM	-40 to 85	(29O4, FA6P, FA6S)	Samples
SN74TVC3306DCURG4	ACTIVE	VSSOP	DCU	8	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	FA6S	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

10-Dec-2020

continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

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TAPE AND REEL INFORMATION





Α0	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74TVC3306DCTR	SM8	DCT	8	3000	180.0	13.0	3.35	4.5	1.55	4.0	12.0	Q3
SN74TVC3306DCTR	SM8	DCT	8	3000	177.8	12.4	3.45	4.4	1.45	4.0	12.0	Q3
SN74TVC3306DCUR	VSSOP	DCU	8	3000	178.0	9.0	2.25	3.35	1.05	4.0	8.0	Q3
SN74TVC3306DCUR	VSSOP	DCU	8	3000	180.0	8.4	2.25	3.35	1.05	4.0	8.0	Q3
SN74TVC3306DCURG4	VSSOP	DCU	8	3000	180.0	8.4	2.25	3.35	1.05	4.0	8.0	Q3

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*All dimensions are nominal

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Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74TVC3306DCTR	SM8	DCT	8	3000	182.0	182.0	20.0
SN74TVC3306DCTR	SM8	DCT	8	3000	183.0	183.0	20.0
SN74TVC3306DCUR	VSSOP	DCU	8	3000	180.0	180.0	18.0
SN74TVC3306DCUR	VSSOP	DCU	8	3000	202.0	201.0	28.0
SN74TVC3306DCURG4	VSSOP	DCU	8	3000	202.0	201.0	28.0

DCU (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE (DIE DOWN)



NOTES:

- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
 - D. Falls within JEDEC MO-187 variation CA.



DCU (S-PDSO-G8)

PLASTIC SMALL OUTLINE PACKAGE (DIE DOWN)



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.





SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.



SMALL OUTLINE PACKAGE



NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



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